

## **Search Notes**



**Application/Control No.**

10/610,683

Examiner

Elizabeth A. Rielley

**Applicant(s)/Patent under  
Reexamination**

HIRASAWA ET AL.

## **Art Unit**

2879

**SEARCHED**

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner